

Search Notes

Application/Control No.

09/108,189

Examiner

Mark K. Han

Applicant(s)/Patent under
Reexamination

TANNER ET AL.

Art Unit

3767

SEARCHED

Class	Subclass	Date	Examiner
604	93.01 96.01	8/21/2006	mah
	158 164.01		
	164.02		
	164.07		
	167.01		
	167.02		
	167.06		
	171 256		
	261 500		
	506 507		
	508 509		
	510 513		
606	192		
	194		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST text search	8/21/2006	mah